

**Search Notes**

Application/Control No.

10/695,046

Applicant(s)/Patent under  
ReexaminationPARSCHE, FRANCIS  
EUGENE

Examiner

Shih-Chao Chen

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
343	700MS, 732, 767, 830, 866, 867	10/24/2005	CHEN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
343	700MS	10/24/2005	CHEN
343	732, 867	10/24/2005	CHEN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Search items: loop antenna, substrate, gap, slot, inner, outer diameter).	10/24/2005	CHEN